

Notice of References Cited	Application/Control No. 09/988,107	Applicant(s)/Patent Under Reexamination HACHISU ET AL.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,603,528	08-2003	Tanaka et al	349/156
	B	US-			
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NON-PATENT DOCUMENTS

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